

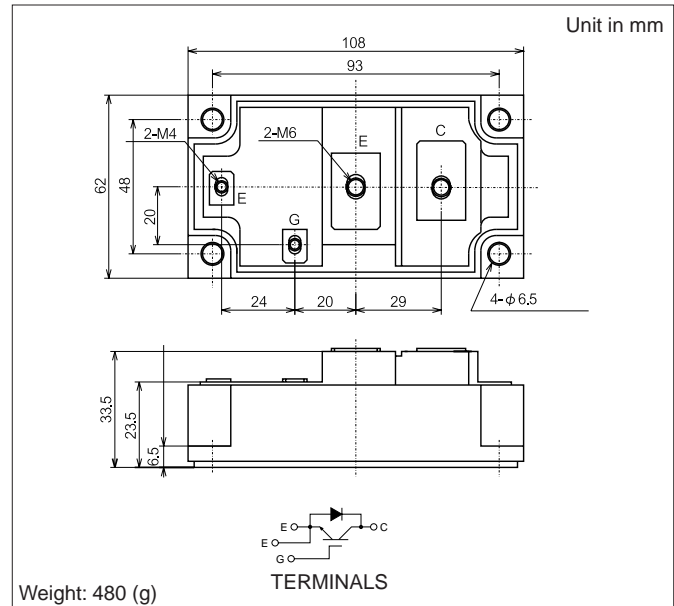
# MBN400GS12BW

Silicon N-channel IGBT

OUTLINE DRAWING

## FEATURES

- \* High speed and low saturation voltage.
- \* low noise due to built-in free-wheeling diode - ultra soft fast recovery diode(USFD).
- \* Isolated head sink (terminal to base).



## ABSOLUTE MAXIMUM RATINGS (T<sub>c</sub>=25°C)

| Item                        | Symbol           | Unit             | MBN400GS12BW          |
|-----------------------------|------------------|------------------|-----------------------|
| Collector Emitter Voltage   | V <sub>CES</sub> | V                | 1,200                 |
| Gate Emitter Voltage        | V <sub>GES</sub> | V                | ±20                   |
| Collector Current           | DC               | I <sub>C</sub>   | 400                   |
|                             | 1ms              | I <sub>Cp</sub>  | 800                   |
| Forward Current             | DC               | I <sub>F</sub>   | 400 (1)               |
|                             | 1ms              | I <sub>FM</sub>  | 800                   |
| Collector Power Dissipation | P <sub>C</sub>   | W                | 2,000                 |
| Junction Temperature        | T <sub>j</sub>   | °C               | -40 ~ +150            |
| Storage Temperature         | T <sub>stg</sub> | °C               | -40 ~ +125            |
| Isolation Voltage           | V <sub>ISO</sub> | V <sub>RMS</sub> | 2,500(AC 1 minute)    |
| Screw Torque                | Terminals        | -                | 1.37(14)/2.94(30) (2) |
|                             | Mounting         | -                | 2.94(30) (3)          |

Notes:(1)RMS Current of Diode 180Arms max.

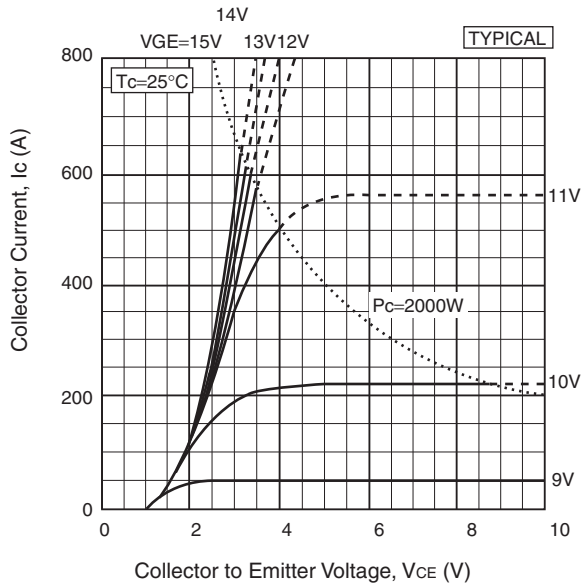
(2)Recommended Value 1.18/2.45N.m(12/25kgf.cm)

(3)Recommended Value 2.45N.m(25kgf.cm)

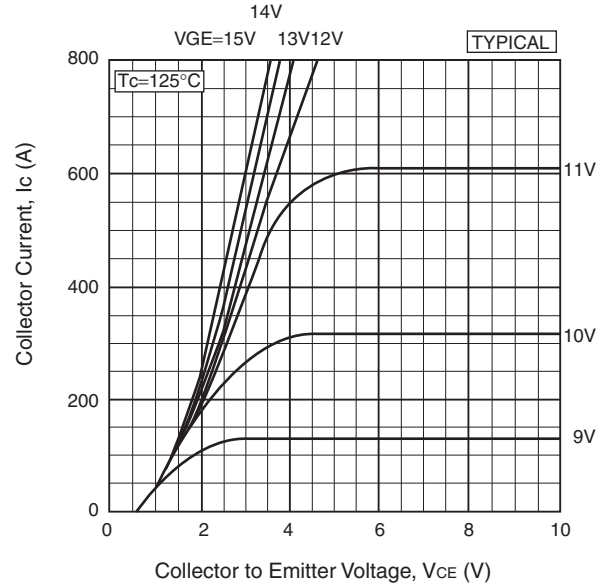
## CHARACTERISTICS (T<sub>c</sub>=25°C)

| Item                                 | Symbol               | Unit                 | Min. | Typ.   | Max. | Test Conditions  |                  |
|--------------------------------------|----------------------|----------------------|------|--------|------|--|------------------|
| Collector Emitter Cut-Off Current    | I <sub>CES</sub>     | mA                   | -    | -      | 1.0  | V <sub>CE</sub> =1,200V, V <sub>GE</sub> =0V   |                  |
| Gate Emitter Leakage Current         | I <sub>GES</sub>     | nA                   | -    | -      | ±500 | V <sub>GE</sub> =±20V, V <sub>CE</sub> =0V   |                  |
| Collector Emitter Saturation Voltage | V <sub>CE(sat)</sub> | V                    | -    | 2.7    | 3.4  | I <sub>C</sub> =400A, V <sub>GE</sub> =15V   |                  |
| Gate Emitter Threshold Voltage       | V <sub>GE(TO)</sub>  | V                    | -    | -      | 10   | V <sub>CE</sub> =5V, I <sub>C</sub> =400mA   |                  |
| Input Capacitance                    | C <sub>ies</sub>     | pF                   | -    | 37,000 | -    | V <sub>CE</sub> =10V, V <sub>GE</sub> =0V, f=1MHz  |                  |
| Switching Times                      | Rise Time            | t <sub>r</sub>       | -    | 0.25   | 0.5  | V <sub>CC</sub> =600V<br>R <sub>L</sub> =1.5Ω<br>R <sub>G</sub> =2.7Ω<br>V <sub>GE</sub> =±15V (4) |                  |
|                                      | Turn On Time         | t <sub>on</sub>      | -    | 0.4    | 0.7  |  |                  |
|                                      | Fall Time            | t <sub>f</sub>       | -    | 0.25   | 0.35 |  |                  |
|                                      | Turn Off Time        | t <sub>off</sub>     | -    | 0.75   | 1.1  |  |                  |
| Peak Forward Voltage Drop            | V <sub>FM</sub>      | V                    | -    | -      | 3.5  | I <sub>F</sub> =400A, V <sub>GE</sub> =0V  |                  |
| Reverse Recovery Time                | t <sub>rr</sub>      | μs                   | -    | -      | 0.4  | I <sub>F</sub> =400A, V <sub>GE</sub> =-10V, di/dt=400A/μs   |                  |
| Thermal Impedance                    | IGBT                 | R <sub>th(j-c)</sub> | °C/W | -      | -    | 0.06   | Junction to case |
|                                      | FWD                  | R <sub>th(j-c)</sub> | °C/W | -      | -    | 0.12   |                  |

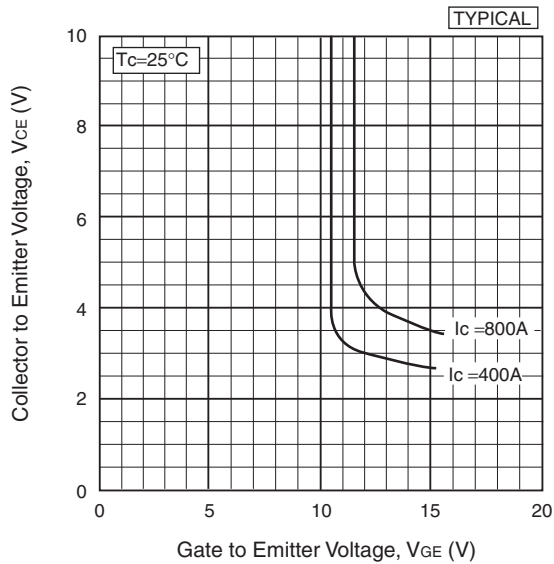
Notes:(4) R<sub>G</sub> value is the test condition's value for decision of the switching times, not recommended value.Determine the suitable R<sub>G</sub> value after the measurement of switching waveforms (overshoot voltage, etc.) with appliance mounted.



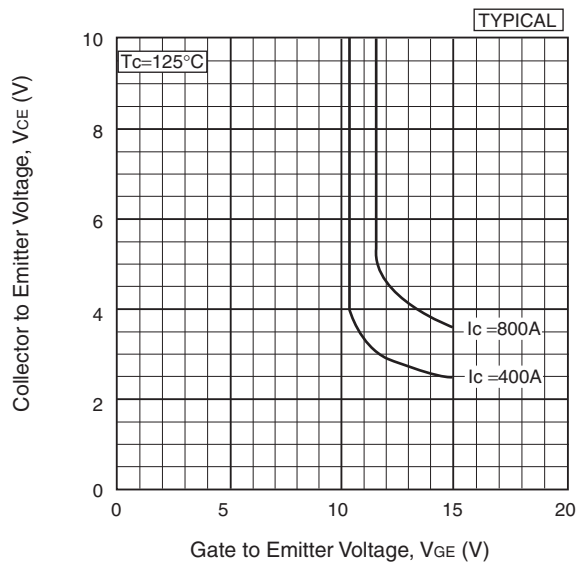
Collector current vs. Collector to Emitter voltage



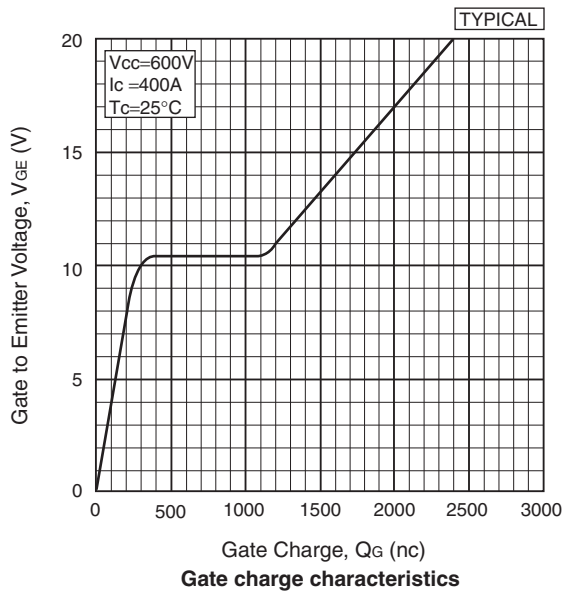
Collector current vs. Collector to Emitter voltage



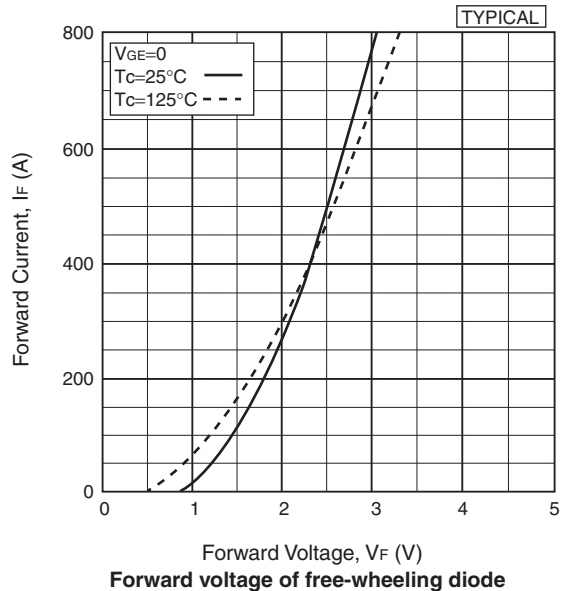
Collector to Emitter voltage vs. Gate to Emitter voltage



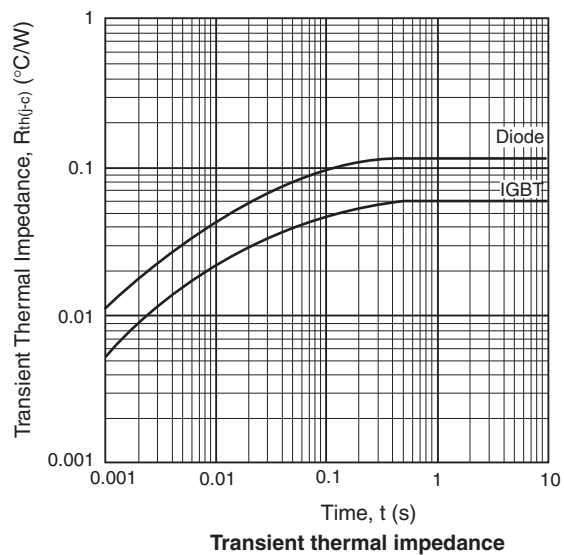
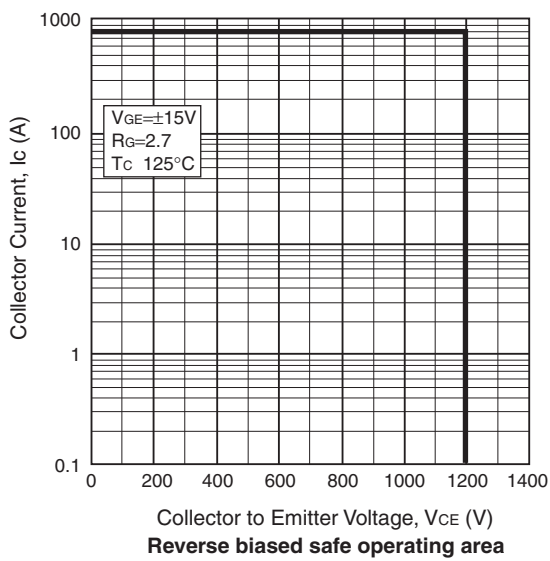
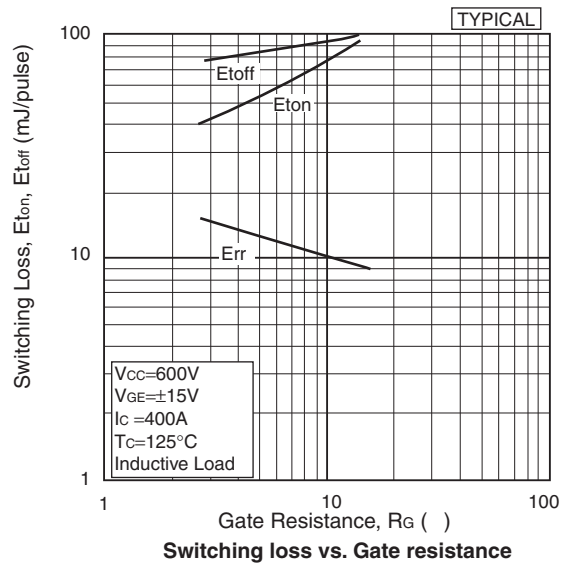
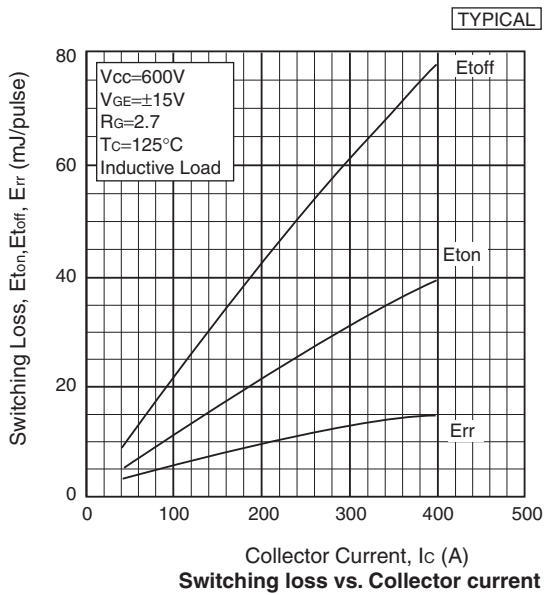
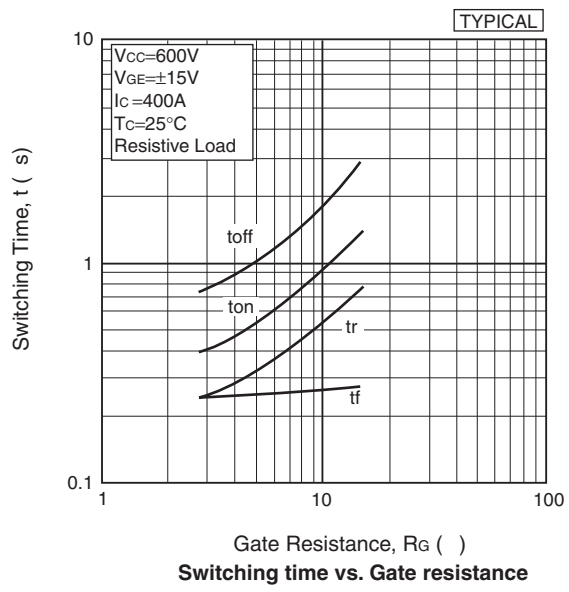
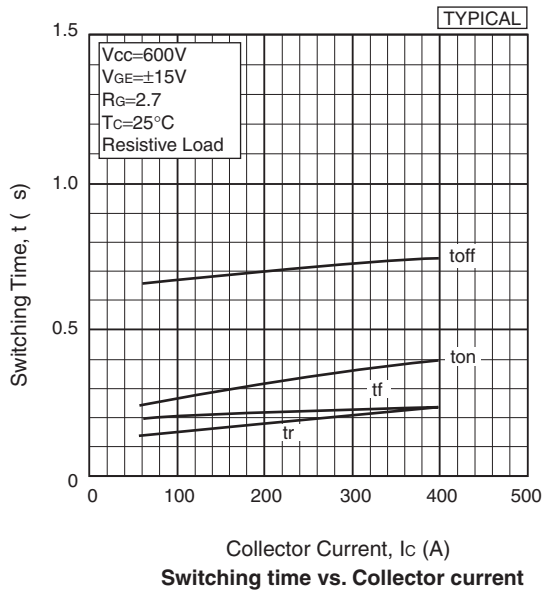
Collector to Emitter voltage vs. Gate to Emitter voltage



Gate charge characteristics



Forward voltage of free-wheeling diode



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